Application/Control No. Applicant(s)/Patent Under Reexamination 10/635,409 HAINES ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 · 2853 Geoffrey Mruk **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 347/93 US-5,481,289 01-1996 Arashima et al. Α Nakano, Hiroshi 347/93 US-5,546,109 08-1996 В C US-US-D US-Ε

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